MSKSEMI 美森科













ESD

MOV

2SK3018(MS)
Product specification





Features

- 30V,300mA, RDS(ON) = 10@VGS = 10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Application

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

BVDSS	RDSON	ID
30V	1Ω	300mA

Reference News

PACKAGE OUTLINE	Pin Configuration	Marking
SOT-23	G	KN

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
L	Drain Current – Continuous (T _A =25°C)	300	mA
lio lio	Drain Current – Continuous (T _A =70°C)	240	mA
Іом	Drain Current – Pulsed¹	1.2	А
D-	Power Dissipation (Tc=25°C)	313	mW
PD	Power Dissipation – Derate above 25°C	2.5	mW/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 125	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA} Thermal Resistance Junction to ambient			400	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=250uA	30			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.05		V/°C
Ipss	Drain-Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =50°C			100	nA
IDSS	Diani-Source Leakage Current	V _{DS} =30V , V _{GS} =0V , T _J =85°C			400	nA
Igss	Gate-Source Leakage Current	V _{GS} = ±20V , V _{DS} =0V			±6	uA

On Characteristics

R _{DS(ON)} Static Drain-Source On-Resistance	Vgs=10V , Ip=0.3A		1.0	3	0	
	Vgs=4.5V , Ip=0.2A		1.3	4	32	
V _G S(th)	Gate Threshold Voltage	Vgs=Vps . Ip =250uA	0.8	1.1	1.6	V
△VGS(th)	V _{GS(th)} Temperature Coefficient	1 00		3		mV/°C

Dynamic and switching Characteristics

Ciss	Input Capacitance		 23	46	
Coss	Output Capacitance	V _{DS} =30V , V _{GS} =0V , F=1MHz	 16	32	pF
Crss	Reverse Transfer Capacitance		 10	20	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V,Force Current			300	mA
lsм	Pulsed Source Current	VG-VD-OV , Force Current			600	mA
VsD	Diode Forward Voltage	Vgs=0V , Is=0.2A , TJ=25°C			1.2	V

Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 3. Essentially independent of operating temperature.

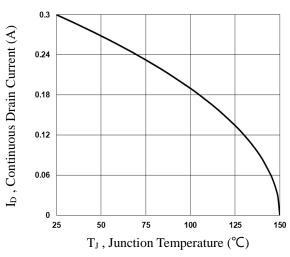


Fig.1 Continuous Drain Current vs. Tc

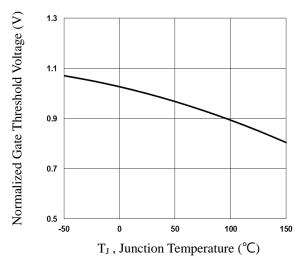


Fig.3 Normalized V_{th} vs. T_J

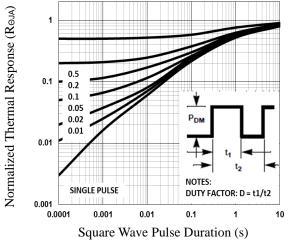


Fig.5 Normalized Transient Response

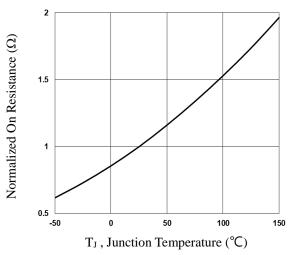
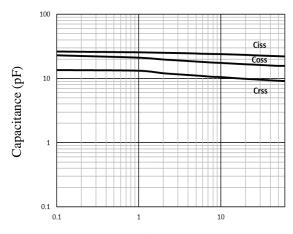


Fig.2 Normalized RDSON vs. TJ



V_{DS}, Drain to Source Voltage

Fig.4 Capacitance Characteristics

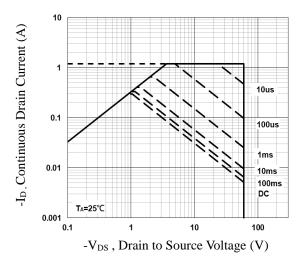
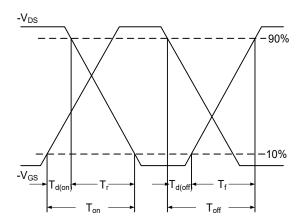


Fig.6 Maximum Safe Operation Area





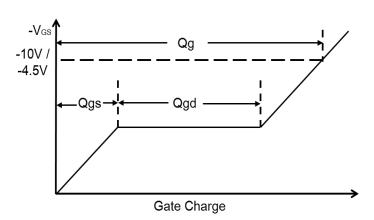
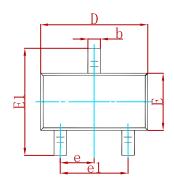
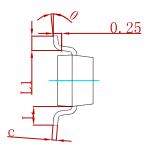


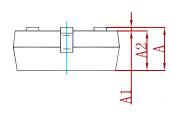
Fig.8 Gate Charge Waveform



PACKAGE MECHANICAL DATA

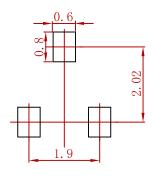






Cumbal	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950 TYP		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

- 1. Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
2SK3018(MS)	SOT-23	3000



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